

## **MOSFET**

### OptiMOS<sup>™</sup> 5 Power-Transistor, 150 V

#### **Features**

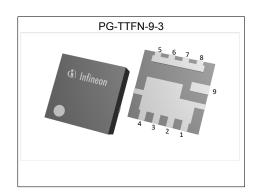
- N-channel
- Superior thermal resistance
- 100% avalanche tested
- Pb-free lead plating; RoHS compliant
  Halogen-free according to IEC61249-2-21
- Optimized for high performance SMPS, e.g. syncronous rectification

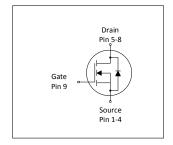
### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Table 1 **Key Performance Parameters** 

Table 1 Rey 1 crioimance 1 arameters						
Parameter	Value	Unit				
<b>V</b> <sub>DS</sub>	150	V				
R <sub>DS(on),max</sub>	22	mΩ				
I <sub>D</sub>	44	A				
Qoss	40	nC				
$Q_{G}$	14.6	nC				











Type / Ordering Code	Package	Marking	Related Links
IQE220N15NM5CG	PG-TTFN-9-3	22015C5	-

# OptiMOS<sup>™</sup> 5 Power-Transistor, 150 V IQE220N15NM5CG



Rev. 2.0, 2022-06-03

## **Table of Contents**

Description	. 1
Maximum ratings	. 3
hermal characteristics	. 3
Electrical characteristics	. 4
Electrical characteristics diagrams	. 6
Package Outlines	10
Revision History	11
rademarks	11
Disclaimer	11

## OptiMOS<sup>™</sup> 5 Power-Transistor, 150 V IQE220N15NM5CG



# 1 Maximum ratings at $T_A$ =25 °C, unless otherwise specified

Table 2 **Maximum ratings** 

Bassassatas	Ob. a.l	Values				Nata / Taat Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	- - -	-	44 31 7	A	$V_{GS}$ =10 V, $T_{C}$ =25 °C $V_{GS}$ =10 V, $T_{C}$ =100 °C $V_{GS}$ =10 V, $T_{A}$ =25 °C, $R_{thJA}$ =60 °C/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	I <sub>D,pulse</sub>	-	-	176	Α	<i>T</i> <sub>A</sub> =25 °C
Avalanche energy, single pulse <sup>4)</sup>	<b>E</b> AS	_	-	40	mJ	$I_D$ =20 A, $R_{GS}$ =25 $\Omega$
Gate source voltage	V <sub>GS</sub>	-20	-	20	V	-
Power dissipation	P <sub>tot</sub>	-	-	100 2.5	W	T <sub>C</sub> =25 °C T <sub>A</sub> =25 °C, R <sub>thJA</sub> =60 °C/W <sup>2)</sup>
Operating and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

#### 2 Thermal characteristics

#### Table 3 Thermal characteristics

Daramatar	Values				Unit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case, bottom	R <sub>thJC</sub>	-	0.8	1.5	°C/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area²)	R <sub>thJA</sub>	-	-	60	°C/W	-

<sup>&</sup>lt;sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.  $^{2)}$  Device on 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain

connection. PCB is vertical in still air.

3) See Diagram 3 for more detailed information

4) See Diagram 13 for more detailed information

## OptiMOS<sup>™</sup> 5 Power-Transistor, 150 V IQE220N15NM5CG



# 3 Electrical characteristics at $T_j$ =25 °C, unless otherwise specified

Table 4 **Static characteristics** 

	0		Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	150	-	-	V	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	
Gate threshold voltage	V <sub>GS(th)</sub>	3.0	3.8	4.6	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =46 μA	
Zero gate voltage drain current	I <sub>DSS</sub>	-	0.1 10	1.0 100	μΑ	V <sub>DS</sub> =120 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C V <sub>DS</sub> =120 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C	
Gate-source leakage current	I <sub>GSS</sub>	-	1.0	100	nA	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	16.9 18.8	22 35	mΩ	V <sub>GS</sub> =10 V, I <sub>D</sub> =16 A V <sub>GS</sub> =8 V, I <sub>D</sub> =8 A	
Gate resistance <sup>1)</sup>	R <sub>G</sub>	-	0.8	1.2	Ω	-	
Transconductance	<b>g</b> fs	-	32	-	S	V <sub>DS</sub>   ≥2  I <sub>D</sub>   R <sub>DS(on)max</sub> , I <sub>D</sub> =22 A	

Table 5 **Dynamic characteristics** 

Devementar	Cumbal	Values			11:4	Nata / Tank Oam distant
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance <sup>1)</sup>	Ciss	-	1100	1400	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =75 V, <i>f</i> =1 MHz
Output capacitance <sup>1)</sup>	Coss	-	270	350	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =75 V, <i>f</i> =1 MHz
Reverse transfer capacitance <sup>1)</sup>	C <sub>rss</sub>	-	8	14	pF	V <sub>GS</sub> =0 V, V <sub>DS</sub> =75 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	8.1	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =22 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Rise time	t <sub>r</sub>	-	1.9	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =22 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Turn-off delay time	$t_{ m d(off)}$	-	8.2	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =22 A, $R_{\rm G,ext}$ =1.6 $\Omega$
Fall time	t <sub>f</sub>	-	2.1	-	ns	$V_{\rm DD}$ =75 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =22 A, $R_{\rm G,ext}$ =1.6 $\Omega$

Gate charge characteristics<sup>2)</sup> Table 6

Parameter	Cumbal	Values			l lmi4	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	6.2	-	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =22 A, $V_{\rm GS}$ =0 to 10 V
Gate charge at threshold	Q <sub>g(th)</sub>	-	4.1	-	nC	$V_{\rm DD}$ =75 V, $I_{\rm D}$ =22 A, $V_{\rm GS}$ =0 to 10 V
Gate to drain charge <sup>1)</sup>	Q <sub>gd</sub>	-	3.2	4.7	nC	V <sub>DD</sub> =75 V, I <sub>D</sub> =22 A, V <sub>GS</sub> =0 to 10 V
Switching charge	Q <sub>sw</sub>	-	5.3	-	nC	V <sub>DD</sub> =75 V, I <sub>D</sub> =22 A, V <sub>GS</sub> =0 to 10 V
Gate charge total <sup>1)</sup>	Qg	-	14.6	18.3	nC	V <sub>DD</sub> =75 V, I <sub>D</sub> =22 A, V <sub>GS</sub> =0 to 10 V
Gate plateau voltage	V <sub>plateau</sub>	-	5.8	-	V	V <sub>DD</sub> =75 V, I <sub>D</sub> =22 A, V <sub>GS</sub> =0 to 10 V
Output charge <sup>1)</sup>	Qoss	-	40	53	nC	V <sub>DS</sub> =75 V, V <sub>GS</sub> =0 V

 $<sup>^{1)}</sup>$  Defined by design. Not subject to production test.  $^{2)}$  See "Gate charge waveforms" for parameter definition

# OptiMOS<sup>TM</sup> 5 Power-Transistor, 150 V IQE220N15NM5CG

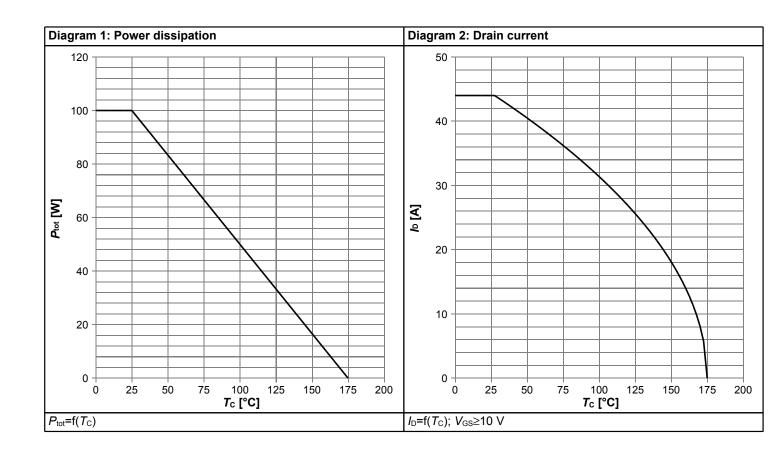


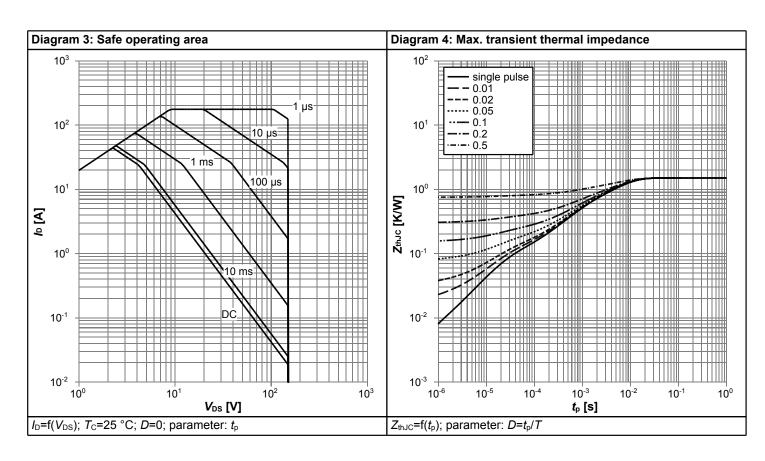
### Table 7 Reverse diode

Dougnator	C: mah al		Values			Nata / Table Operation
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current	Is	-	-	44	Α	T <sub>C</sub> =25 °C
Diode pulse current	I <sub>S,pulse</sub>	-	-	176	Α	T <sub>C</sub> =25 °C
Diode forward voltage $V_{\rm SI}$		-	0.86	1.2	V	V <sub>GS</sub> =0 V, I <sub>F</sub> =22 A, T <sub>j</sub> =25 °C
Reverse recovery time <sup>1)</sup> $t_{rr}$		-	25	50	ns	V <sub>R</sub> =75 V, I <sub>F</sub> =22 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs
Reverse recovery charge <sup>1)</sup>	Qrr		17	34	nC	V <sub>R</sub> =75 V, I <sub>F</sub> =22 A, d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/μs

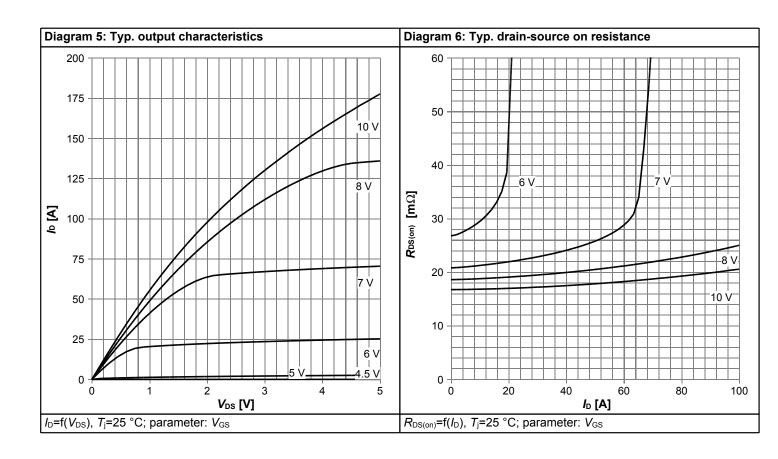


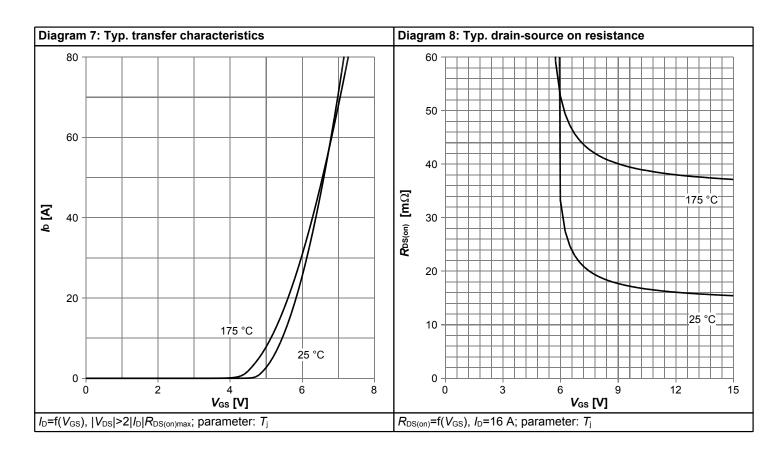
## 4 Electrical characteristics diagrams



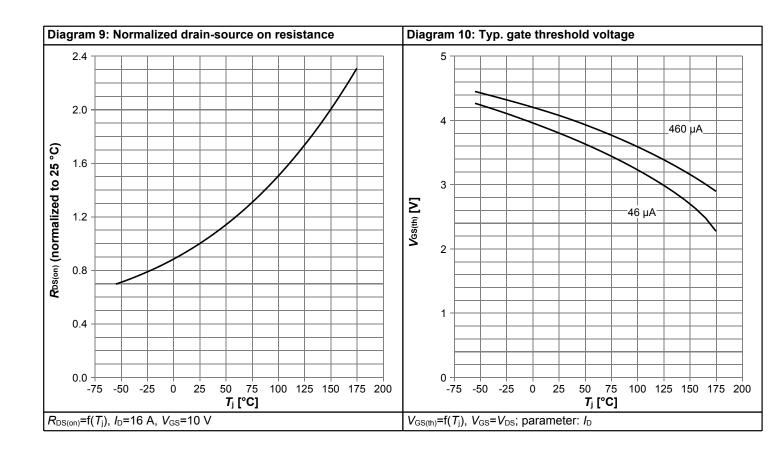


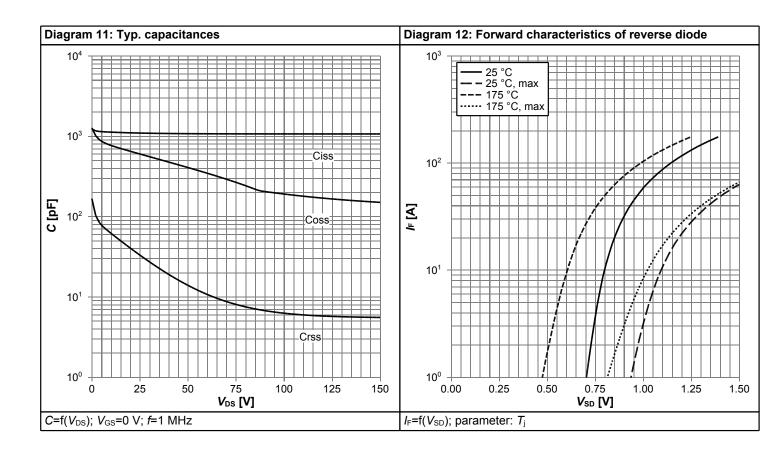




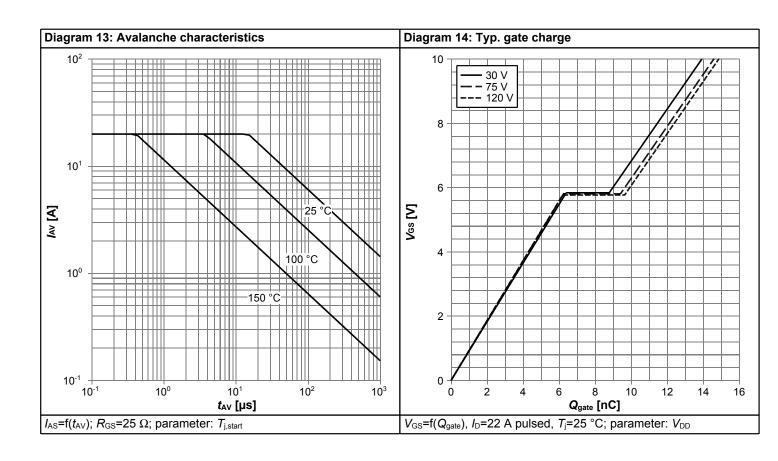


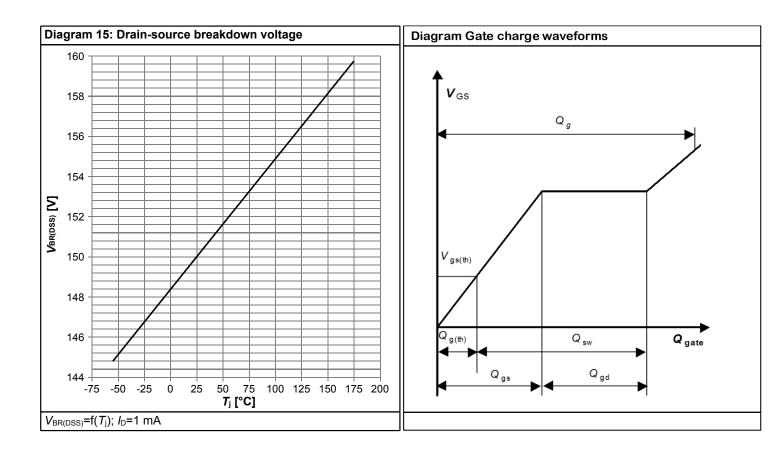






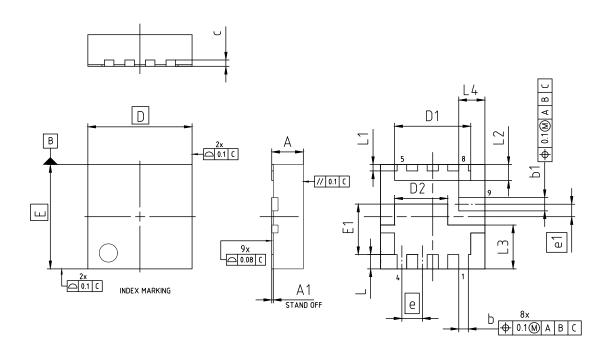








# 5 Package Outlines



DIMENSION	MILLIM	IETERS				
DIMENSION	MIN.	MAX.				
Α	-	1.10				
A1	-	0.05				
b	0.20	0.40				
b1	0.32	0.52				
С	0.	20				
D	3.30					
D1	2.31	2.51				
D2	1.58	1.78				
E	3.30					
E1	1.50	1.70				
е	0.65					
e1	0.395					
L	0.35	0.55				
L1	0.10	0.30				
L2	0.40	0.60				
L3	1.285	1.485				
L4	0.73	0.93				

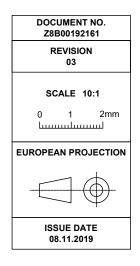


Figure 1 Outline PG-TTFN-9-3, dimensions in mm

# OptiMOS<sup>™</sup> 5 Power-Transistor, 150 V



#### **Revision History**

IQE220N15NM5CG

Revision: 2022-06-03, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2022-06-03	Release of final version				

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Final Data Sheet 11 Rev. 2.0, 2022-06-03